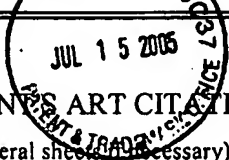
		Application 10/758,568		OFGS File No. P/1929-91			
		Applicant Michiaki OMURA					
		Filing Date January 14, 2004		Group Art Unit 2143			
U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)							
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate	
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/M.K./	WO 02/075504 A2	09-2002	PCT			X	
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/M.K./		English Translation of Chinese Office Action issued December 20, 2005 in connection					
		with corresponding Chinese application no. 20041000363.3					
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.							

 <p>APPLICANT'S ART CITATION (Use several sheets if necessary)</p>		Application 10/758,568		OFGS File No. P/1929-91			
		Applicant Michiaki OMURA					
		Filing Date January 14, 2004		Group Art Unit 2143			
U.S. PATENT DOCUMENTS (not submitted for applications filed after 6/30/03)							
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/M.K./	US-2002/0003803	01-2002	Kametani				
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	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
/M.K./	WO 02/074054	26.09.02	PCT				
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/M.K./		Communication from European Patent Office on June 2, 2005 in Connection with Corresponding European Application No. 04090014.4-1244.					
Examiner /Michael Keefer/		Date Considered 10/10/2007					
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APPLICANT'S ART CITATION (Use several sheets if necessary)		Application		OFGS File No. P/1929-91			
		Applicant Michiaki OMURA					
		Filing Date		Group Art Unit			
U.S. PATENT DOCUMENTS							
Examiner Initial	Document Number	Date MM-YYYY	Name	Class	Sub-class	Filing Date If Appropriate	
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FOREIGN PATENT DOCUMENTS							
	Document Number	Date MM-YYYY	Country	Class	Sub-class	Translation	
						Yes	No
/M.K./	2002-176637	06-2002	Japan			X (abstract only)	
/M.K./	2002-176445	06-2002	Japan			X (abstract only)	
/M.K./	2001-358777	12-2001	Japan			X (abstract only)	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
Examiner /Michael Keefer/		Date Considered 10/10/2007					
<small>EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.</small>							